

PMV130ENEA 40 V, N-channel Trench MOSFET

12 June 2014

Product data sheet

1. General description

N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

2. Features and benefits

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology
- 1 kV ESD protected
- AEC-Q101 qualified

3. Applications

- Relay driver
- High-speed line driver
- Low-side load switch
- Switching circuits

4. Quick reference data

Table 1. Quick reference data							
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
V _{DS}	drain-source voltage	T _j = 25 °C		-	-	40	V
V _{GS}	gate-source voltage	-		-20	-	20	V
I _D	drain current	V _{GS} = 10 V; T _{amb} = 25 °C	[1]	-	-	2.1	А
Static characteristics							
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 1.5 A; T _j = 25 °C		-	95	120	mΩ

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm².





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5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	3	D
2	S	source		
3	D	drain		G (」 片 本)
	D	drain	1 2 TO-236AB (SOT23)	S 017aaa255

6. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
PMV130ENEA	TO-236AB	plastic surface-mounted package; 3 leads	SOT23			

7. Marking

Table 4. Marking codes	
Type number	Marking code
	[1]
PMV130ENEA	%JX

[1] % = placeholder for manufacturing site code

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8. Limiting values

Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
V _{DS}	drain-source voltage	T _j = 25 °C		-	40	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{amb} = 25 °C	[1]	-	2.1	А
		V _{GS} = 10 V; T _{amb} = 100 °C	[1]	-	1.3	А
I _{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \ \mu s$		-	8	А
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$T_{j(init)}$ = 25 °C; I _D = 0.26 A; DUT in avalanche (unclamped)		-	5.8	mJ
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	460	mW
			[1]	-	833	mW
		T _{sp} = 25 °C		-	5000	mW
Tj	junction temperature			-55	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C
Source-drai	in diode		1			,
I _S	source current	T _{amb} = 25 °C	[1]	-	0.8	А
ESD maxim	um rating					
V _{ESD}	electrostatic discharge voltage	НВМ	[3]	-	1000	V

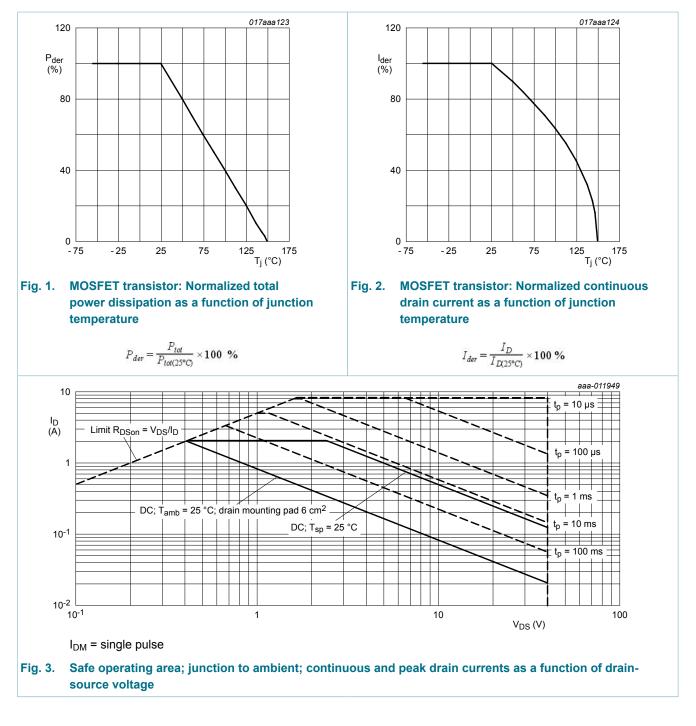
[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm².

[2] Device mounted on an FR4 Printed Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[3] Measured between all pins.

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9. Thermal characteristics

Table 6. The	rmal characteristics						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{th(j-a)} thermal resistance from junction to ambient		in free air	[1]	-	235	270	K/W
	-	[2]	-	125	150	K/W	

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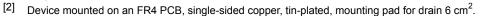
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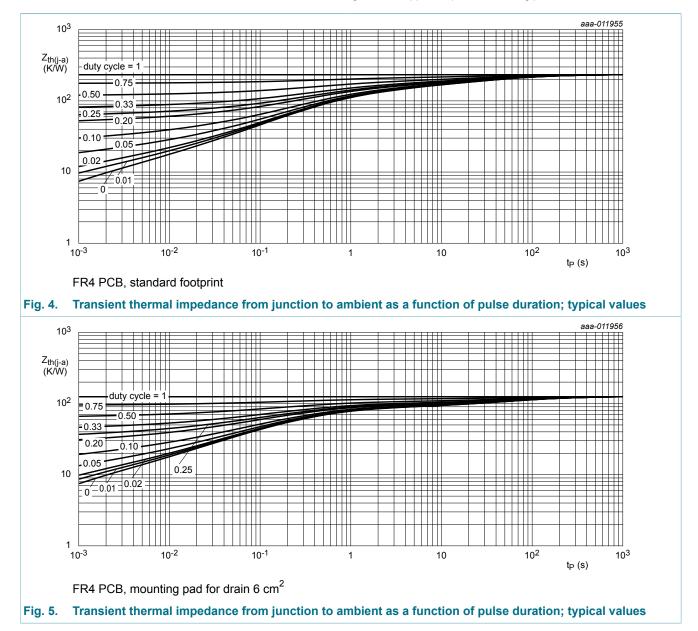
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Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point		-	20	25	K/W

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.





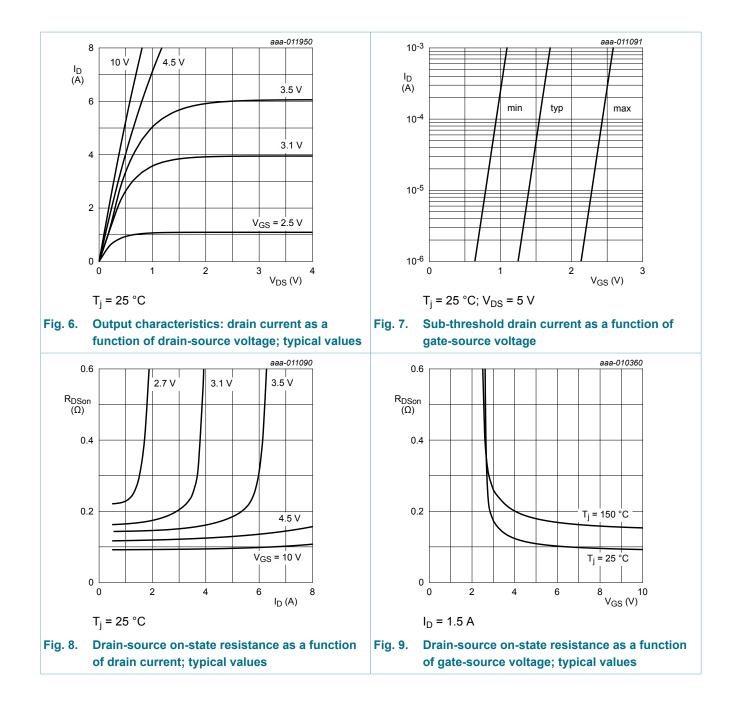
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10. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	octeristics		I			
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	40	-	-	V
V _{GSth}	gate-source threshold voltage	I_D = 250 µA; V_{DS} = V_{GS} ; T_j = 25 °C	1	1.6	2.5	V
I _{DSS}	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	-	1	μA
		V_{DS} = 40 V; V_{GS} = 0 V; T_j = 150 °C	-	-	20	μA
I _{GSS}	gate leakage current	V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	-	10	μA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	-	-10	μA
20011	drain-source on-state	V_{GS} = 10 V; I _D = 1.5 A; T _j = 25 °C	-	95	120	mΩ
	resistance	V _{GS} = 10 V; I _D = 1.5 A; T _j = 150 °C	-	160	200	mΩ
		V _{GS} = 4.5 V; I _D = 1 A; T _j = 25 °C	-	120	160	mΩ
9 _{fs}	forward transconductance	V _{DS} = 10 V; I _D = 2 A; T _j = 25 °C	-	4.5	-	S
R _G	gate resistance	f = 1 MHz; T _j = 25 °C	-	21	-	Ω
Dynamic ch	aracteristics		'			
Q _{G(tot)}	total gate charge	V_{DS} = 20 V; I _D = 1.5 A; V _{GS} = 10 V;	-	2.4	3.6	nC
Q _{GS}	gate-source charge	T _j = 25 °C	-	0.3	-	nC
Q _{GD}	gate-drain charge		-	0.4	-	nC
C _{iss}	input capacitance	V _{DS} = 20 V; f = 1 MHz; V _{GS} = 0 V;	-	113	170	pF
C _{oss}	output capacitance	T _j = 25 °C	-	27	-	pF
C _{rss}	reverse transfer capacitance		-	14	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 20 V; I _D = 1.5 A; V _{GS} = 10 V;	-	6	9	ns
t _r	rise time	R _{G(ext)} = 13 Ω; T _j = 25 °C	-	8	-	ns
t _{d(off)}	turn-off delay time	1 [-	11	17	ns
t _f	fall time		-	3	-	ns
Source-drai	n diode	·	I			
V _{SD}	source-drain voltage	I _S = 0.8 A; V _{GS} = 0 V; T _i = 25 °C	-	0.8	1.2	V

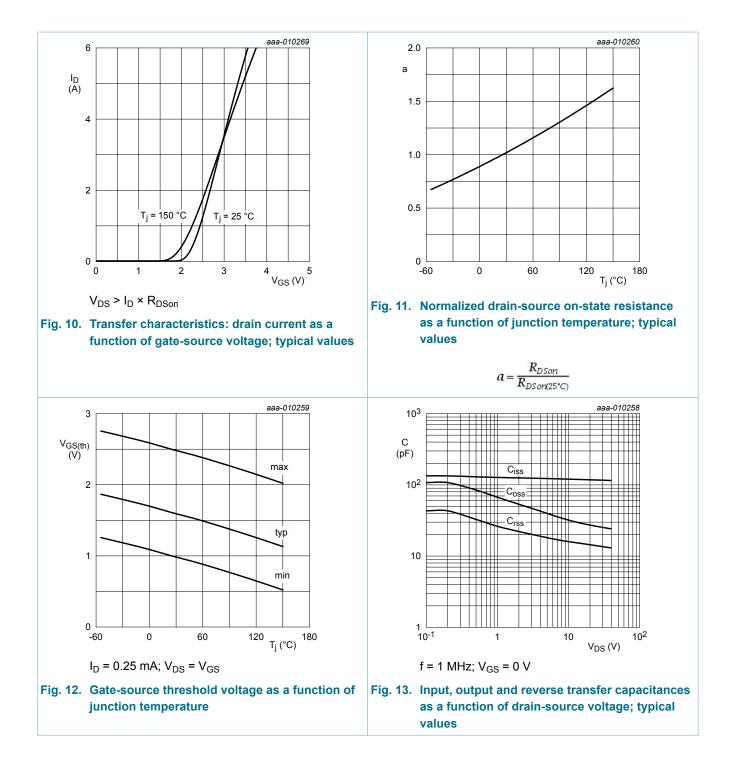
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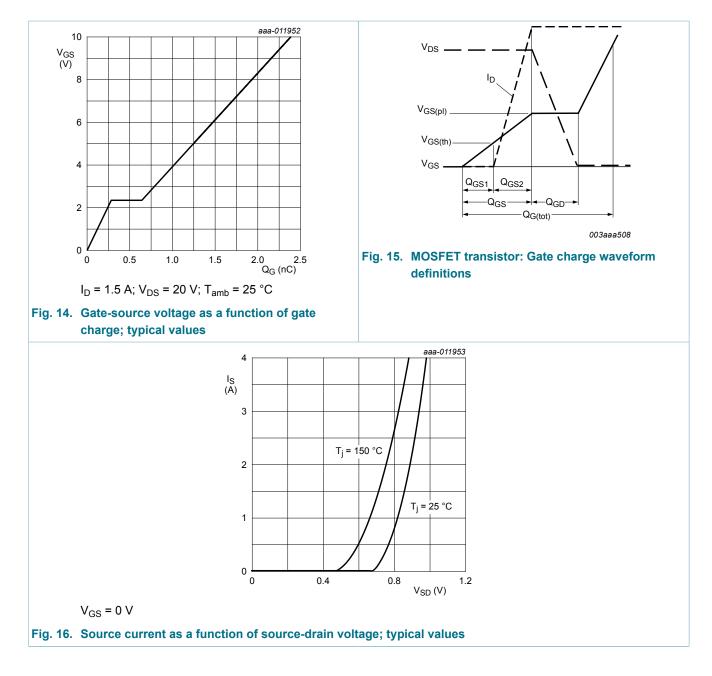
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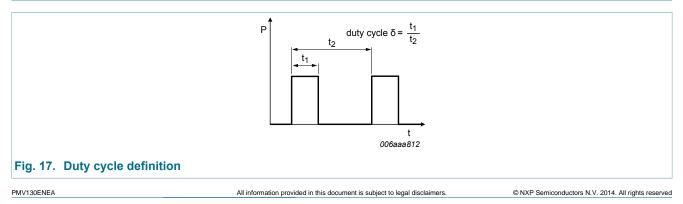


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11. Test information



11.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

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12. Package outline

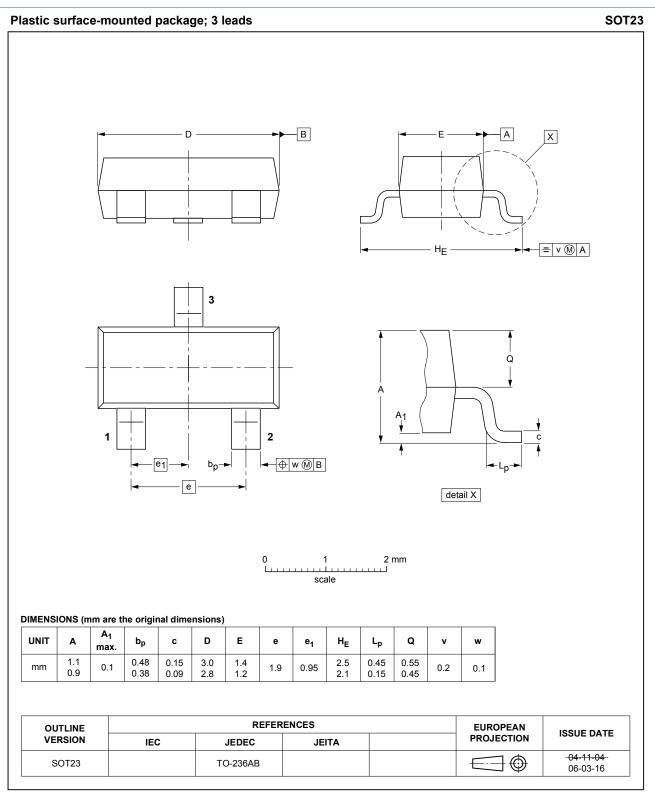


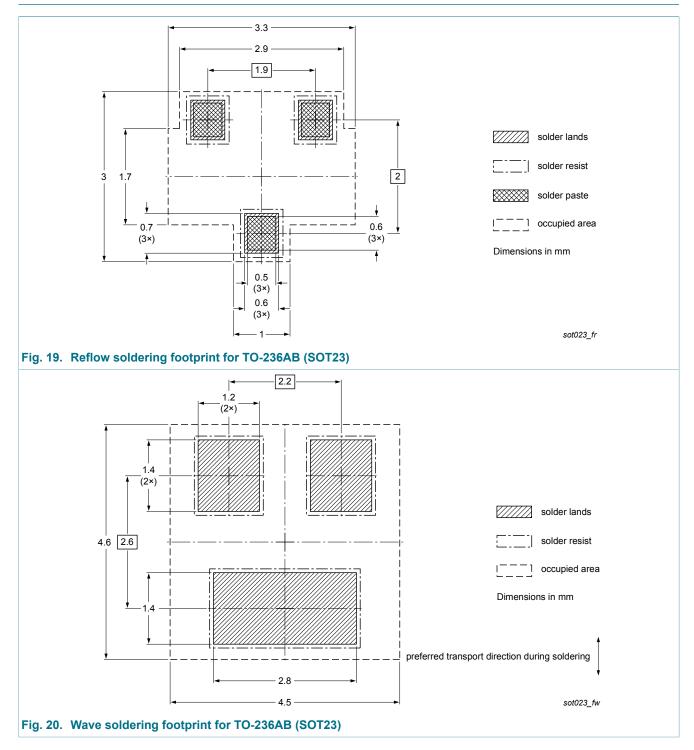
Fig. 18. Package outline TO-236AB (SOT23) PMV130ENEA All informa

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13. Soldering



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14. Revision history

Table 8. Revision history							
Data sheet ID	Release date	Data sheet status	Change notice	Supersedes			
PMV130ENEA v.2	20140612	Product data sheet	-	PMV130ENEA v.1			
Modifications: Product status changed.							
PMV130ENEA v.1	20140313	Preliminary data sheet	-	-			

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15. Legal information

15.1 Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

 Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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